

**IN THE UNITED STATES PATENT AND TRADEMARK OFFICE**

Applicants: S. KASUKABE et al

Application No.: 10/562,797

Filed: 12/29/2005

Title: PROBE CARD AND SEMICONDUCTOR TESTING DEVICE  
USING PROBE SHEET OR PROBE CARD AND  
SEMICONDUCTOR DEVICE PRODUCING METHOD

Art Unit: 2829 Exr.: R. ISLA RODAS **CONF. No.: 8707**

**AMENDMENT**

**MS: AMENDMENT**  
Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

**September 24, 2007**

Sir:

In response to the Office Action dated April 24, 2007, the period of response for which extension is requested by the attached Petition for Extension of Time, please amend the above-identified application as listed below and as set forth on the following pages:

**Amendments to the Claims;**

**Remarks are included following the amendments.**